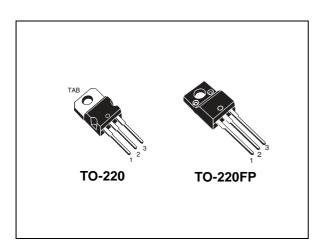


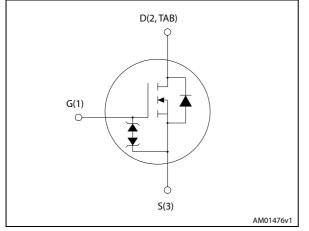
# STP4NK60Z, STP4NK60ZFP

Datasheet - production data

### N-channel 600 V, 1.7 Ω typ., 4 A Zener-protected SuperMESH<sup>™</sup> Power MOSFETs in TO-220 and TO-220FP packages



### Figure 1. Internal schematic diagram



### Features

Order codes	$v_{\text{DS}}$	R <sub>DS(on) max.</sub>	P <sub>TOT</sub>	Ι <sub>D</sub>
STP4NK60Z	600 V	20	70 W	4 A
STP4NK60ZFP		2 12	70 W	4 A

- 100% avalanche tested
- Very low intrinsic capacitances
- Zener-protected

### **Applications**

• Switching applications

### Description

These devices are N-channel Zener-protected Power MOSFETs developed using STMicroelectronics' SuperMESH<sup>™</sup> technology, achieved through optimization of ST's well established strip-based PowerMESH<sup>™</sup> layout. In addition to a significant reduction in onresistance, this device is designed to ensure a high level of dv/dt capability for the most demanding applications.

#### Table 1. Device summary

Order codes	Marking	Packages	Packaging
STP4NK60Z	P4NK60Z	TO-220	Tube
STP4NK60ZFP	P4NK60ZFP	TO-220FP	Tube

DocID025020 Rev 2

This is information on a product in full production.

## Contents

1	Electrical ratings
2	Electrical characteristics4
	2.1 Electrical characteristics (curves) 6
3	Test circuits
4	Package mechanical data 10
5	Revision history15



## 1 Electrical ratings

Symbol	Parameter	Va	lue	Unit
Symbol	Falameter	TO-220	TO-220FP	Onic
V <sub>DS</sub>	Drain-source voltage	60	00	V
V <sub>GS</sub>	Gate- source voltage	±	30	V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	4	4 <sup>(1)</sup>	А
Ι <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	2.5	2.5 <sup>(1)</sup>	А
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	16	16 <sup>(1)</sup>	А
P <sub>TOT</sub>	Total dissipation at $T_C = 25 \ ^{\circ}C$	70	25	W
	Derating factor	0.56	0.2	W/°C
ESD	Gate-source human body model (C=100 pF, R=1.5 $k\Omega)$	;	3	kV
dv/dt <sup>(3)</sup>	Peak diode recovery voltage slope	4	.5	V/ns
V <sub>ISO</sub>	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; $T_C$ =25 °C)		2500	V
T <sub>stg</sub>	Storage temperature	-55 te	o 150	°C
Тj	Max operating junction temperature	1	50	°C

#### Table 2. Absolute maximum ratings

1. Limited by maximum junction temperature.

2. Pulse width limited by safe operating area

3.  $I_{SD} \leq$  4 A, di/dt  $\leq$  200 A/µs, V<sub>DD</sub>  $\leq$  V<sub>(BR)DSS</sub>, T<sub>J</sub>  $\leq$  T<sub>JMAX</sub>.

#### Table 3. Thermal data

Symbol	Parameter	Va	lue	Unit
Symbol	Farameter	TO-220	TO-220FP	Onic
R <sub>thj-case</sub>	Thermal resistance junction-case max	1.79	5	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient max	62	2.5	°C/W

#### Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I <sub>AR</sub>	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_{j max}$ )	4	А
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_J = 25 \text{ °C}, I_D = I_{AR}, V_{DD} = 50 \text{ V}$ )	120	mJ



### 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

	10					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	I <sub>D</sub> =1 mA	600			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 600 V V <sub>DS</sub> = 600 V, T <sub>C</sub> = 125 °C			1 50	μΑ μΑ
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20 V			± 10	μA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 50 \mu A$	3	3.75	4.5	V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2 A		1.7	2	Ω

Table	5.	On/o	off	states
-------	----	------	-----	--------

#### Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
g <sub>fs</sub> <sup>(1)</sup>	Forward transconductance	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 2 \text{ A}$	-	3		S
C <sub>iss</sub>	Input capacitance		-	510		pF
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> = 25 V, f = 1 MHz, V <sub>GS</sub> = 0	-	67		pF
C <sub>rss</sub>	Reverse transfer capacitance	165 - 0	-	13		pF
C <sub>oss eq.</sub> <sup>(2)</sup>	Equivalent output capacitance	$V_{DS} = 0, V_{DS} = 0 \text{ to } 480 \text{ V}$	-	38.5		pF
t <sub>d(on)</sub>	Turn-on delay time		-	12		ns
t <sub>r</sub>	Rise time	$V_{DD} = 300 \text{ V}, I_D = 2 \text{ A},$	-	9.5		ns
t <sub>d(off)</sub>	Turn-off delay time	R <sub>G</sub> = 4.7 Ω, V <sub>GS</sub> = 10 V (see <i>Figure 17</i> )	-	29		ns
t <sub>f</sub>	Fall time		-	16.5		ns
t <sub>r(Voff)</sub>	Off-voltage rise time	V <sub>DD</sub> = 480 V, I <sub>D</sub> = 4 A,	-	12		ns
t <sub>r</sub>	Fall time	R <sub>G</sub> = 4.7 Ω, V <sub>GS</sub> = 10 V	-	12		ns
t <sub>c</sub>	Cross-over time	(see Figure 19)	-	19.5		ns
Qg	Total gate charge	V <sub>DD</sub> = 480 V, I <sub>D</sub> = 4 A,	-	18.8	26	nC
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> = 10 V	-	3.8		nC
Q <sub>gd</sub>	Gate-drain charge	(see <i>Figure 18</i> )	-	9.8		nC

1. Pulsed: pulse duration= $300\mu$ s, duty cycle 1.5%

2.  $C_{oss eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ .



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		-		4	А
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		16	А
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 4 \text{ A}, V_{GS} = 0$	-		1.6	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 4 A, di/dt = 100 A/μs	-	400		ns
Q <sub>rr</sub>	Reverse recovery charge	V <sub>DD</sub> = 24 V, Tj = 150 °C	-	1700		nC
I <sub>RRM</sub>	Reverse recovery current	(see <i>Figure 19</i> )	-	8.5		А

Table 7. Source drain diode

1. Pulsed: pulse duration =  $300 \,\mu$ s, duty cycle 1.5%

2. Pulse width limited by safe operating area

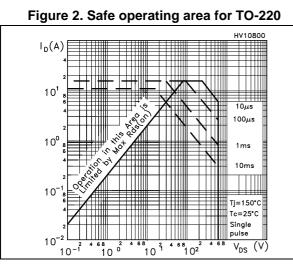
Table 8. Gate-source Zener diode

Symbol	Parameter	Test conditions	Min	Тур.	Max.	Unit
V <sub>(BR)GSO</sub>	Gate-source breakdown voltage	$I_{GS} = \pm 1$ mA, $I_{D}=0$	30	-	-	V

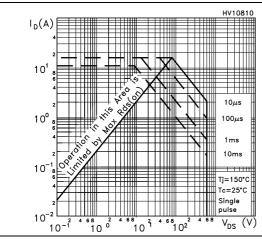
The built-in back-to-back Zener diodes have been specifically designed to enhance not only the device's ESD capability, but also to make them capable of safely absorbing any voltage transients that may occasionally be applied from gate to source. In this respect, the Zener voltage is appropriate to achieve efficient and cost-effective protection of device integrity. The integrated Zener diodes thus eliminate the need for external components.



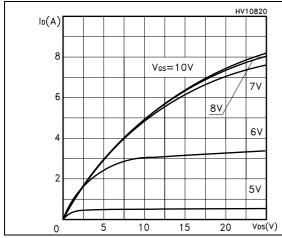
### 2.1 Electrical characteristics (curves)



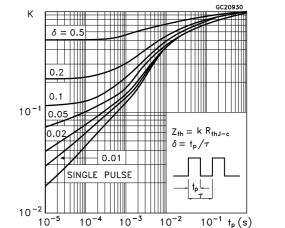




### Figure 6. Output characteristics









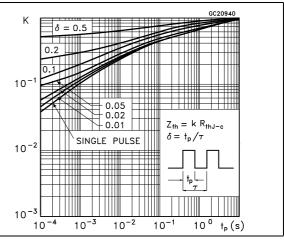
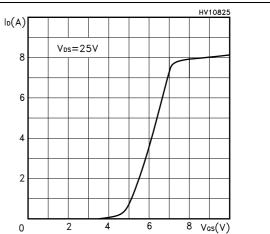


Figure 7. Transfer characteristics





#### Figure 8. Transconductance

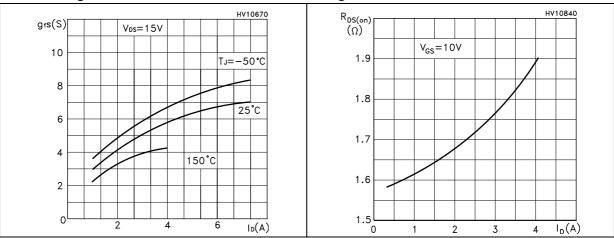


Figure 10. Gate charge vs gate-source voltage

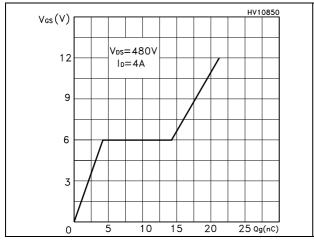


Figure 12. Normalized gate threshold voltage vs temperature

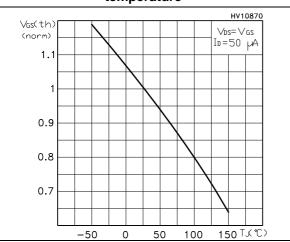




Figure 9. Static drain-source on-resistance

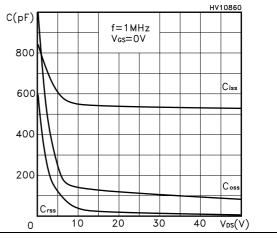


Figure 13. Normalized R<sub>DS(on)</sub> vs temperature

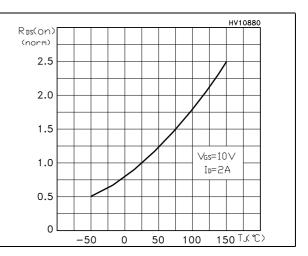




Figure 14. Source-drain diode forward characteristic

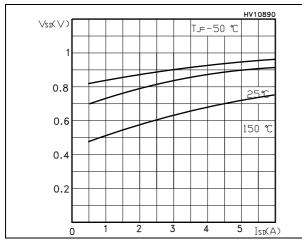
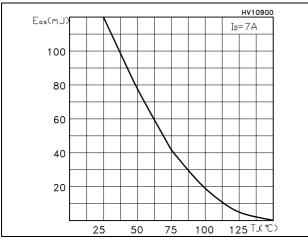
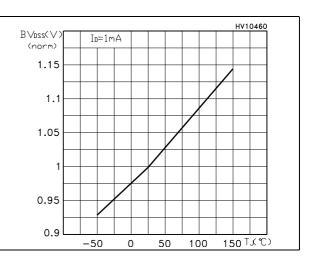


Figure 16. Avalanche energy vs temperature



### Figure 15. Normalized $V_{\text{DS}}$ vs temperature





### 3 Test circuits

Figure 17. Switching times test circuit for resistive load

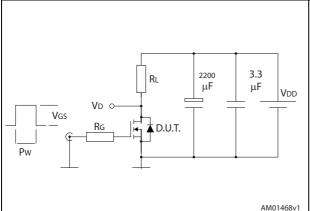


Figure 19. Test circuit for inductive load switching and diode recovery times

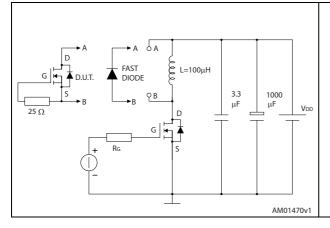


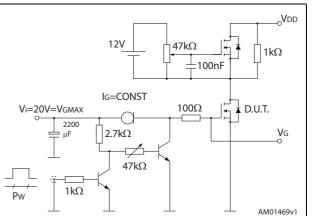
Figure 21. Unclamped inductive waveform

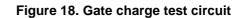
VD

IDM

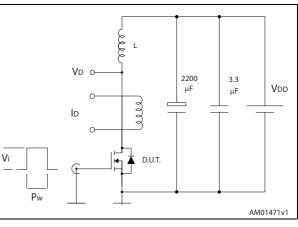
lр

V(BR)DSS









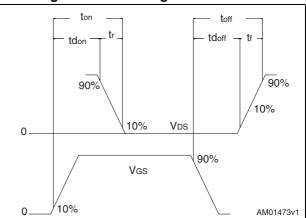


Figure 22. Switching time waveform



Vdd

DocID025020 Rev 2

Vdd

AM01472v1

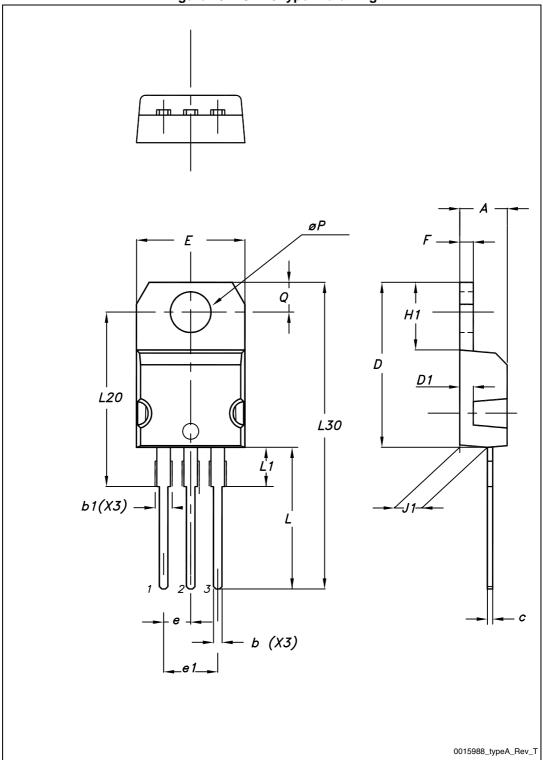
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.

10/16



Figure 23. TO-220 type A drawing





DocID025020 Rev 2

1	Table 9. TO-220 type A mechanical data					
Dim.		mm				
Dim.	Min.	Тур.	Max.			
А	4.40		4.60			
b	0.61		0.88			
b1	1.14		1.70			
с	0.48		0.70			
D	15.25		15.75			
D1		1.27				
E	10		10.40			
е	2.40		2.70			
e1	4.95		5.15			
F	1.23		1.32			
H1	6.20		6.60			
J1	2.40		2.72			
L	13		14			
L1	3.50		3.93			
L20		16.40				
L30		28.90				
Øр	3.75		3.85			
Q	2.65		2.95			

Table 9. TO-220 type A mechanical data



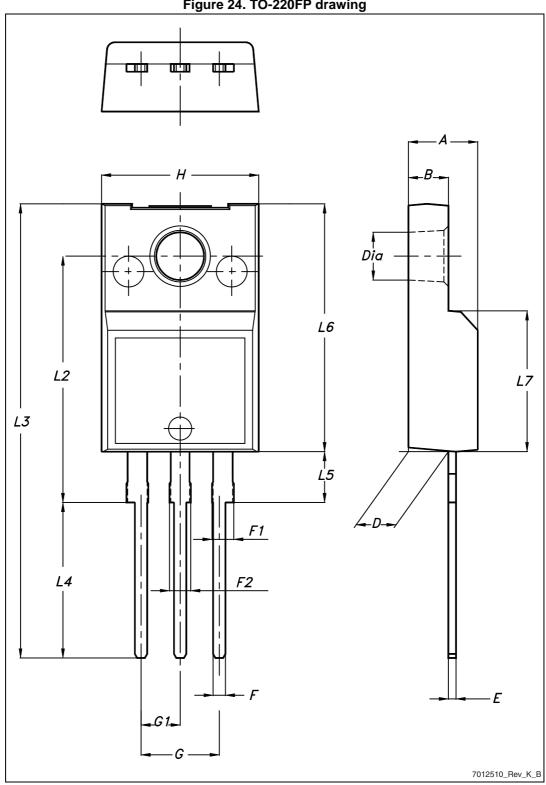


Figure 24. TO-220FP drawing



Table 10. TO-220FP mechanical data				
Dim	mm			
	Min.	Тур.	Max.	
А	4.4		4.6	
В	2.5		2.7	
D	2.5		2.75	
E	0.45		0.7	
F	0.75		1	
F1	1.15		1.70	
F2	1.15		1.70	
G	4.95		5.2	
G1	2.4		2.7	
Н	10		10.4	
L2		16		
L3	28.6		30.6	
L4	9.8		10.6	
L5	2.9		3.6	
L6	15.9		16.4	
L7	9		9.3	
Dia	3		3.2	

Table 10. TO-220FP mechanical data



## 5 Revision history

Date	Revision	Changes	
19-Jul-2013	1	First release. Part numbers previously included in datasheet DocID8882	
22-Jan-2014	2	<ul> <li>Modified: figure in cover page</li> <li>Minor text changes</li> </ul>	

#### Table 11. Document revision history



#### Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

ST PRODUCTS ARE NOT DESIGNED OR AUTHORIZED FOR USE IN: (A) SAFETY CRITICAL APPLICATIONS SUCH AS LIFE SUPPORTING, ACTIVE IMPLANTED DEVICES OR SYSTEMS WITH PRODUCT FUNCTIONAL SAFETY REQUIREMENTS; (B) AERONAUTIC APPLICATIONS; (C) AUTOMOTIVE APPLICATIONS OR ENVIRONMENTS, AND/OR (D) AEROSPACE APPLICATIONS OR ENVIRONMENTS. WHERE ST PRODUCTS ARE NOT DESIGNED FOR SUCH USE, THE PURCHASER SHALL USE PRODUCTS AT PURCHASER'S SOLE RISK, EVEN IF ST HAS BEEN INFORMED IN WRITING OF SUCH USAGE, UNLESS A PRODUCT IS EXPRESSLY DESIGNATED BY ST AS BEING INTENDED FOR "AUTOMOTIVE, AUTOMOTIVE SAFETY OR MEDICAL" INDUSTRY DOMAINS ACCORDING TO ST PRODUCT DESIGN SPECIFICATIONS. PRODUCTS FORMALLY ESCC, QML OR JAN QUALIFIED ARE DEEMED SUITABLE FOR USE IN AEROSPACE BY THE CORRESPONDING GOVERNMENTAL AGENCY.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries. Information in this document supersedes and replaces all information previously supplied. The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2014 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan -Malaysia - Malta - Morocco - Philippines - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

DocID025020 Rev 2

